

Notice of References Cited	Application/Control No. 10/516,936	Applicant(s)/Patent Under Reexamination KOBAYASHI ET AL.	
	Examiner Meless N. Zewdu	Art Unit 2683	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,351,499 B1	02-2002	Paulraj et al.	375/267
*	B	US-5,440,590	08-1995	Birchler et al.	375/347
*	C	US-2003/0123559 A1	07-2003	Classon et al.	375/260
*	D	US-6,801,790 B1	10-2004	Rudrapatna, Ashok N.	455/562.1
*	E	US-2003/0147458 A1	08-2003	Hamied et al.	375/215
*	F	US-2003/0185241 A1	10-2003	Lu et al.	370/476
*	G	US-6,683,916 B1	01-2004	Sartori et al.	375/295
*	H	US-2001/0004374 A1	06-2001	Kono, Masaki	375/130
*	I	US-2003/0125040 A1	07-2003	Walton et al.	455/454
*	J	US-6,934,320 B2	08-2005	Tujkovic et al.	375/146
*	K	US-6,628,733 B1	09-2003	Tomiyoshi et al.	375/347
*	L	US-5,329,555	07-1994	Marko et al.	375/347
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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